

## Nano4me.org Video Download

E SC 216: Characterization, Testing of Nanotechnology Structures, and Materials

### Unit 4: Advanced Scanning Probe Microscopy



#### Lecture 1

**Length:** 52:14

This video will cover:

- Overview of Scanning Probe Techniques
- Scanning Tunneling Microscopy
- Atomic Force Microscopy
- Hardware and Components
- Tip/Sample Interactions

Thank You For Watching!

What did you think? [Email](#) Bob Ehrmann with your feedback.

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